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Modelling of the influence of the CdZnTe substrate thickness on the response of IR HgCdTe photodetectors under proton irradiation





CEA - LETI/Optronics Department (Grenoble, France)

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DeMo – June 2020

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MODEL

EXPERIMENTAL VALIDATION

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ALFA (Astronomical Large Format Array) detector : equip Europe with high performance IR detectors for space applications and astrophysics

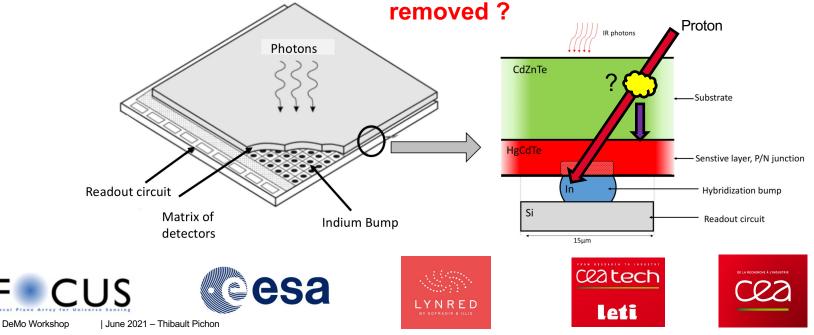
- <u>Development :</u>
 - Lynred + CEA-Leti

CONTEXT

- <u>Characterisation :</u>
 - Astrophysics Department, CEA
- Funding :
 - ESA, FOCUS

- <u>ALFA Specifications:</u>
 - HgCdTe
 - 2048x2048 with a pixel pitch of 15µm.
 - Spectral domain 0.8µm to 2.1µm.

What happens under irradiation when the CZT substrate is not

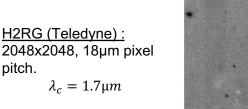




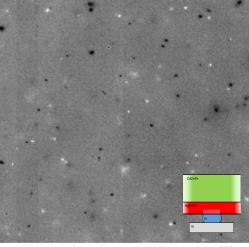
MODEL

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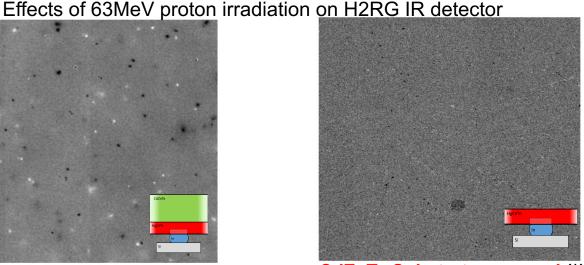
CONCLUSIONS



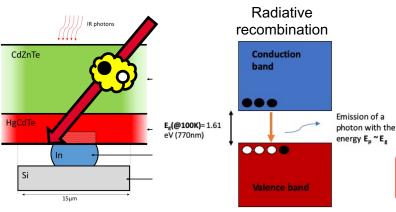
CONTEXT



Intact Substrate CdZnTe(*). Substrate Thickness 800µm



CdZnTe Substrate removed (*)



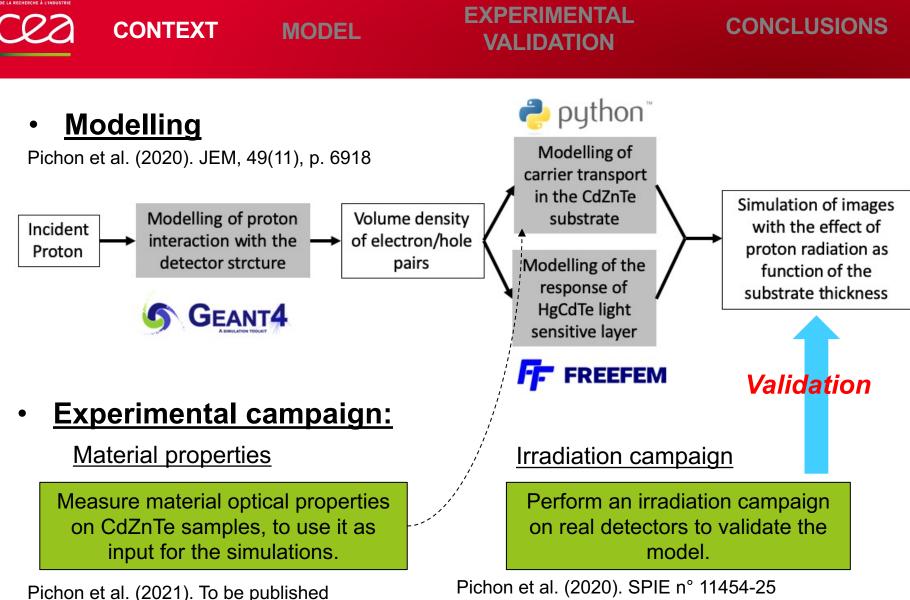
Proton irradiation on substrate intact IR detector:

- 1 Induce large cluster of pixels
- 2 Increase in the detector background (suspected to be linked to CZT luminescence)

However, substrate removal is a tricky step in the fabrication process.

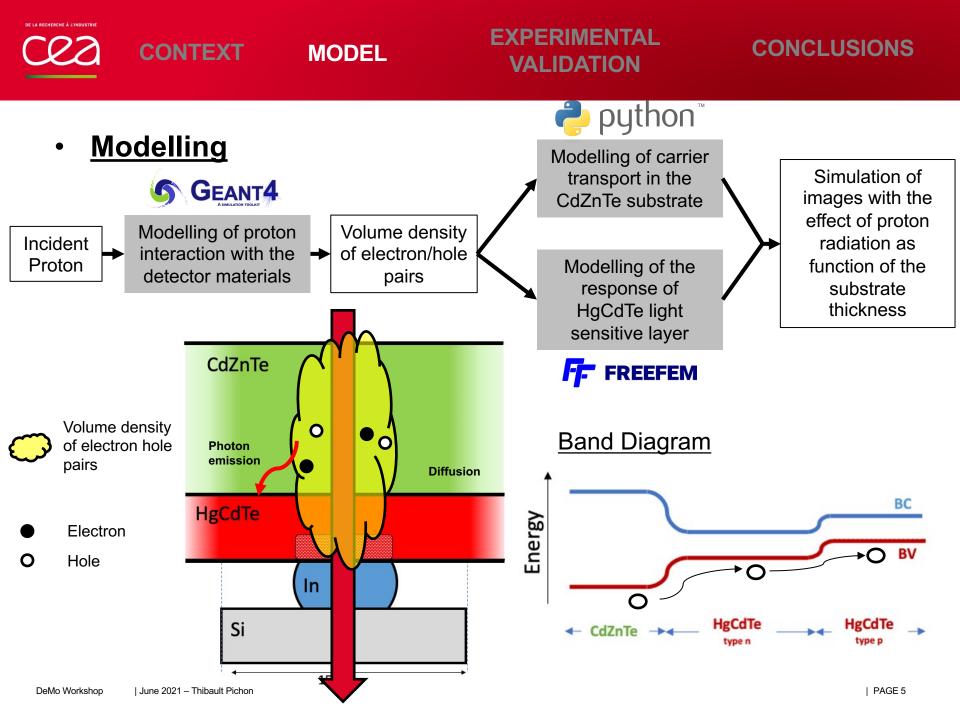
Which substrate thickness can we keep?

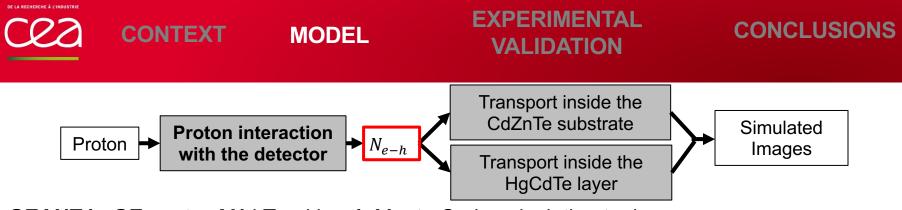
(*)Noise and Zero point drift in 1.7um cutoff detectors for SNAP, Smith et al. Proceeding of SPIE (2006)



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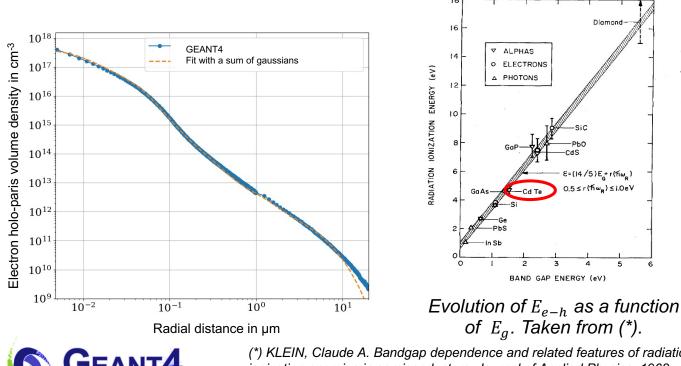
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GEANT4 : GEometry ANd Tracking 4. Monte Carlo calculation tool.

<u>Method</u> : Localization of energy deposited as a function of radial distance from proton impact \rightarrow Fiitted with a sum of gaussian functions.



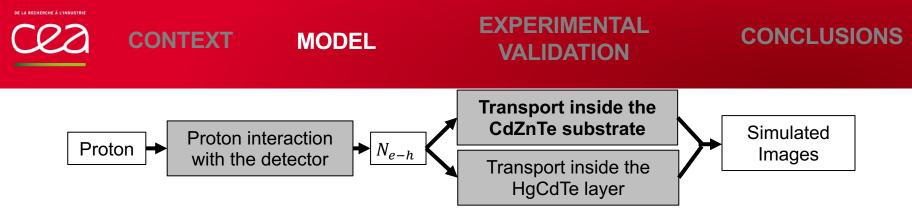
Electron-hole pairs volume density is calculated using the mean energy of creation of one electron hole pair E_{e-h} .

$$E_{e-h} \sim 3E_g$$

$$N_{e-h} = \frac{E_{deposited}}{E_{e-h}}$$



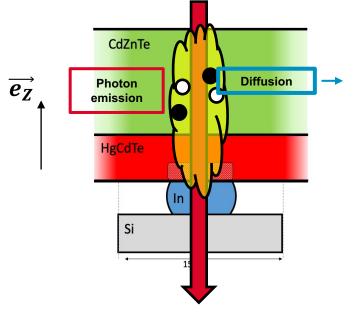
(*) KLEIN, Claude A. Bandgap dependence and related features of radiation ionization energies in semiconductors. Journal of Applied Physics, 1968, vol. 39, no 4, p. 2029-2038.



- → Electron-hole pairs are generared **close to the proton trajectory**
- → Hence we have a gradient in the carrier concentration

→ Carriers will diffuse

Solving the diffusion equation, enables us to know the carriers density, $\Pi(\vec{x}, t)$, at any time and any point in the CdZnTe substrate.



Diffusion current density expresses as :

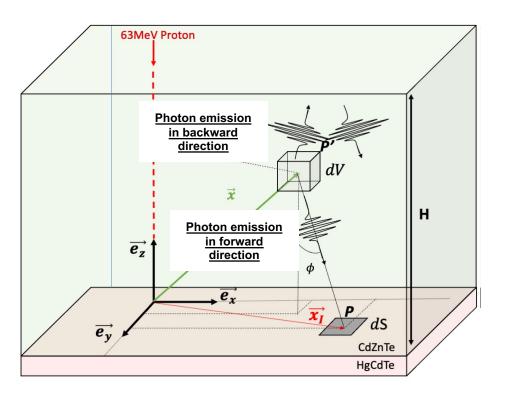
$$J_{\text{diff}}(\overrightarrow{x_{I}},t) = -D^{*} \overrightarrow{\text{grad}} \left(\Pi(\overrightarrow{x_{I}},t) \right) \cdot \overrightarrow{e_{Z}}$$

The total number of charge at the CdZnTe/HgCdTe interface expresed in e-h/cm2 is then :

$$Q(x_I) = \int_t J_{diff}(x_I, t) dt$$



Modelling of the luminescence of the CdZnTe substrate



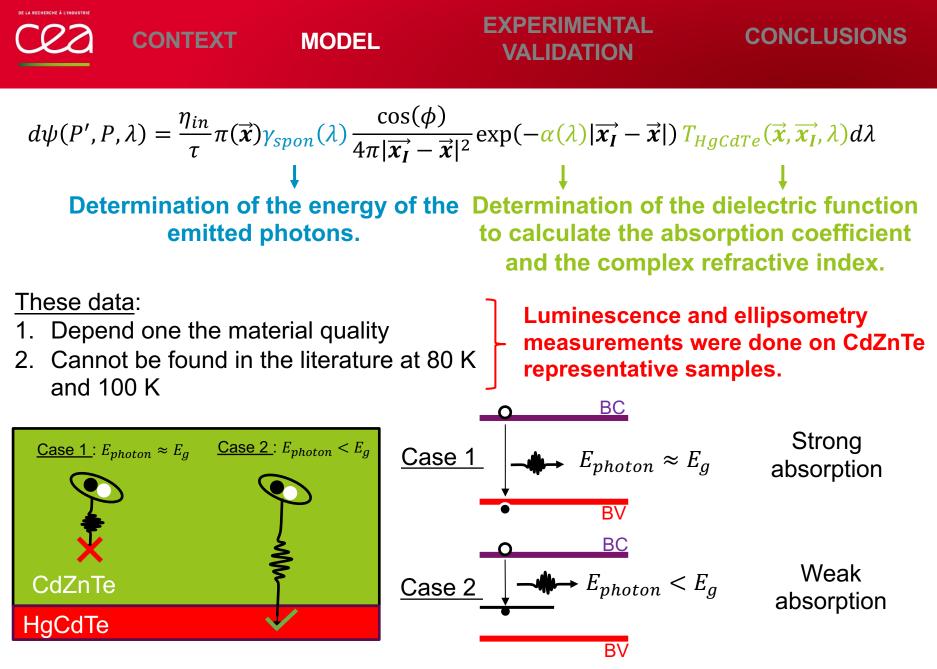
Phenomenological model:

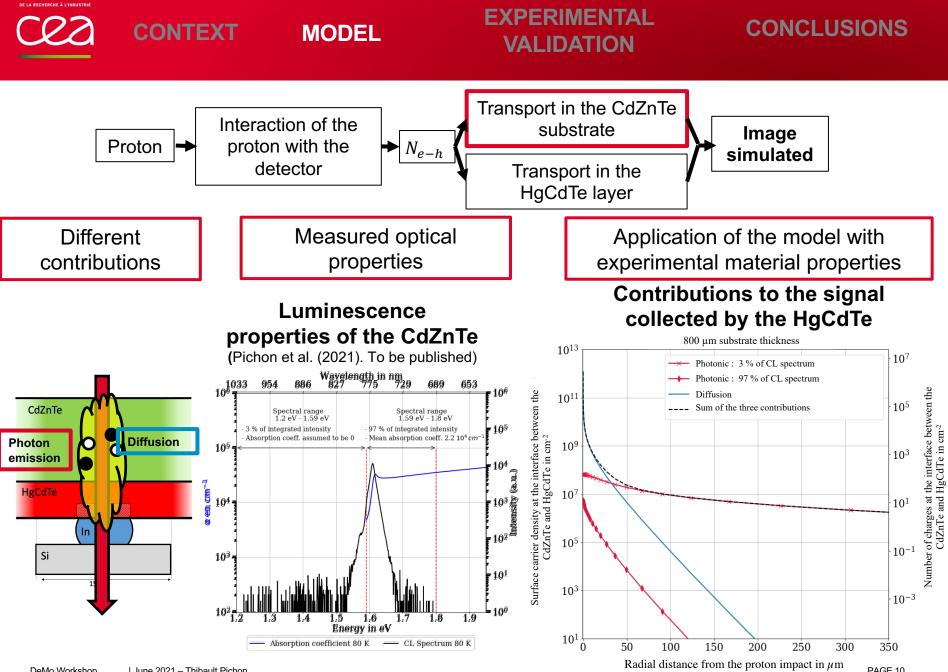
Let's calculate the number of photons emitted at point P' and received at point P $d\psi(P', P, \lambda)$

- 1. Count **the number of photons** emitted by radiative recombination
- 2. Take into account the wavelength of these photons (emission spectrum)
- 3. Consider photon emission in the solid angle $d\Omega$
- 4. Take into account **optical losses** (absorption and reflection/transmission)

The total number of photons recieved at the point P, in unit of photons/cm2 is then written as follows :

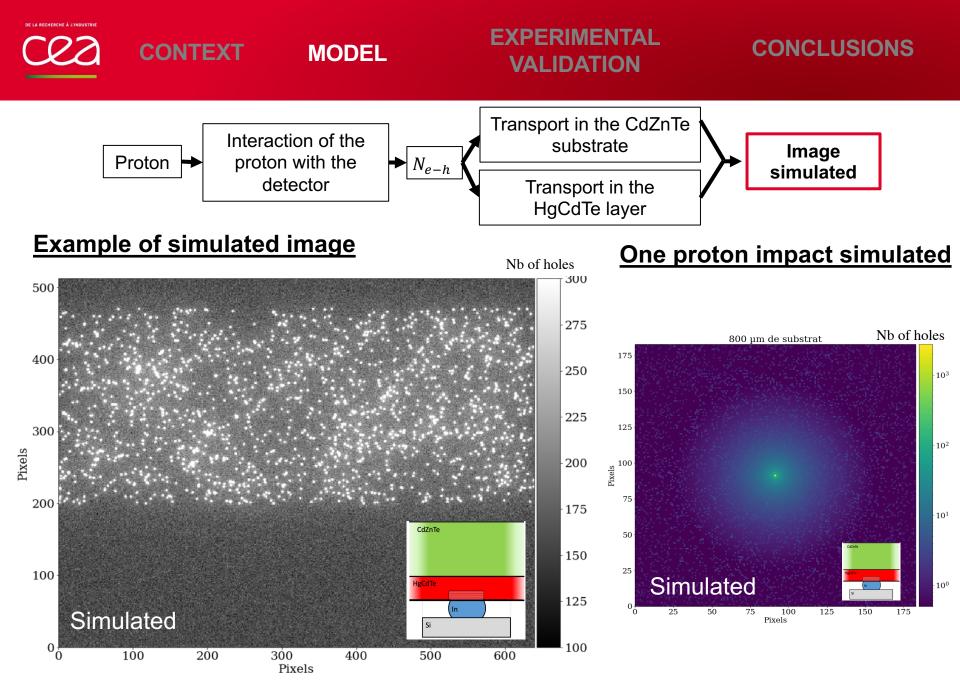
$$\psi(P) = \int_{P'} \int_{\lambda} d\psi(P', P, \lambda)$$





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Arro ARRONAX

CONTEXT

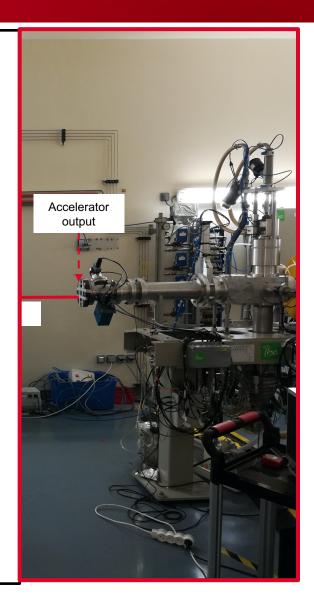
Arronax cyclotron in Nantes (France)

Arronax aims at producing innovative radionuclides for research in **nuclear medicine** and at performing research in radiochemistry on radiolysis.

Features of the irradiation facility

- Particles: protons, alphas et deutons
- Proton energy: de 30 MeV à 70 MeV 🗸

- Very low flux < 100 protons/s/cm² √



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Two test detectors have been manufactured at CEA-Leti

Unshielded area

	NIR50	NIR800	ALFA
	NINGU	NIKOUU	
Name	1901	1903	-
Absorbing material	HgCdTe	HgCdTe	HgCdTe
Format [pixels × pixels]	640x512	640x512	2048x2048
Pixel pitch	15 µm	15 µm	15 µm
Cut off wavelength	2.1 µm	2.1 µm	2.1 µm
CdZnTe substrate thickness	50 µm	800 µm	< 30 µm
Scheme	Cd2nTe HgCate (n	CdZnTe HgCdTe (In) Si	CdZnTe HaCdTe (In Si
Underfill	Yes	No	Yes
Diode technology	p/n	p/n	p/n
ROIC	SFD	SFD	SFD
Readout time	400 ms	400 ms	1.31 s
Operating temperature	80 K	80 K	100 K



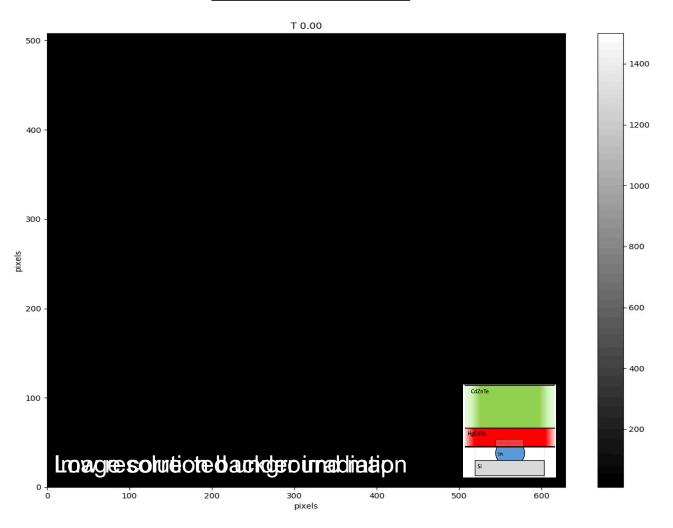


CONTEXT MODEL

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Détecteur NIR800



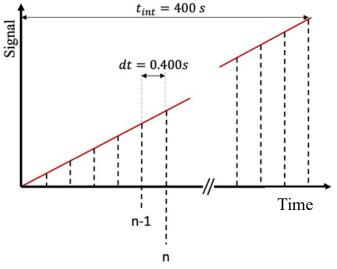
EXPERIMENTAL VALIDATION

CONCLUSIONS

Non-destructive readout (FUR mode, Following Up the Ramp) $t_{int} = 400 s$

MODEL

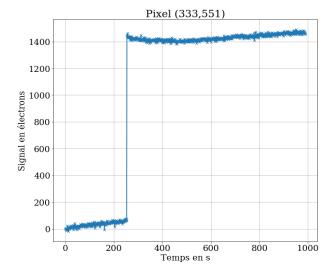
CONTEXT



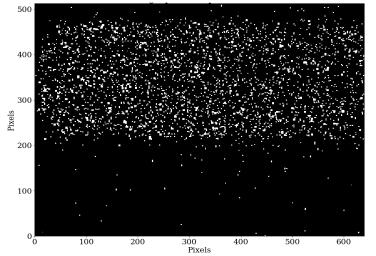
Proton impacts are detected with **SExtractor** (Source Extractor) applied to the difference of two consecutives images

Pixels marked as affected by a proton = signal 3σ higher than the background signal

Example of pixels affected by a proton



Map of proton impacts detected by SExtractor



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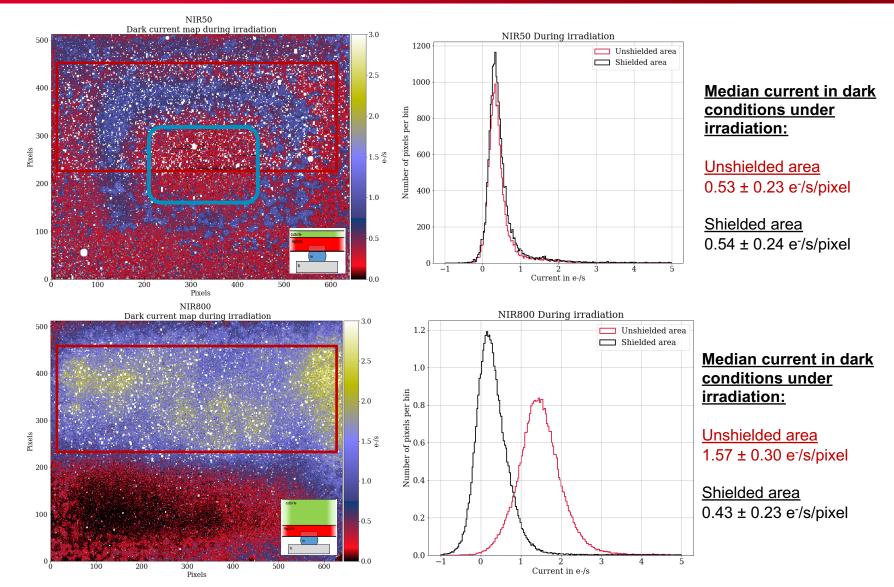
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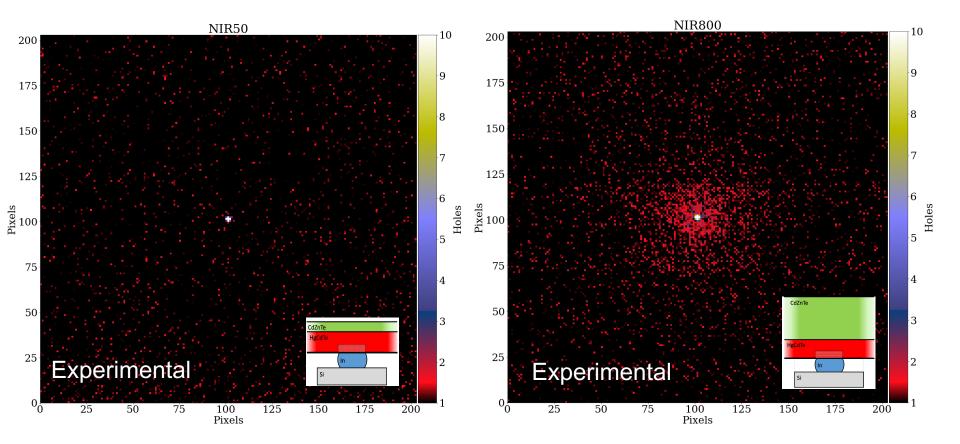
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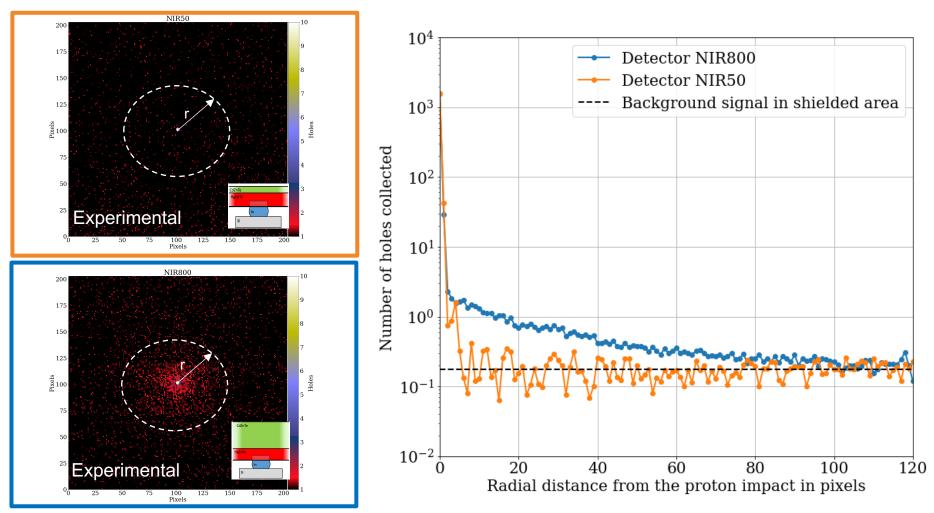
CONCLUSIONS

Mean clusters





Radial profile: Average of the pixels at equidistance of the proton impact



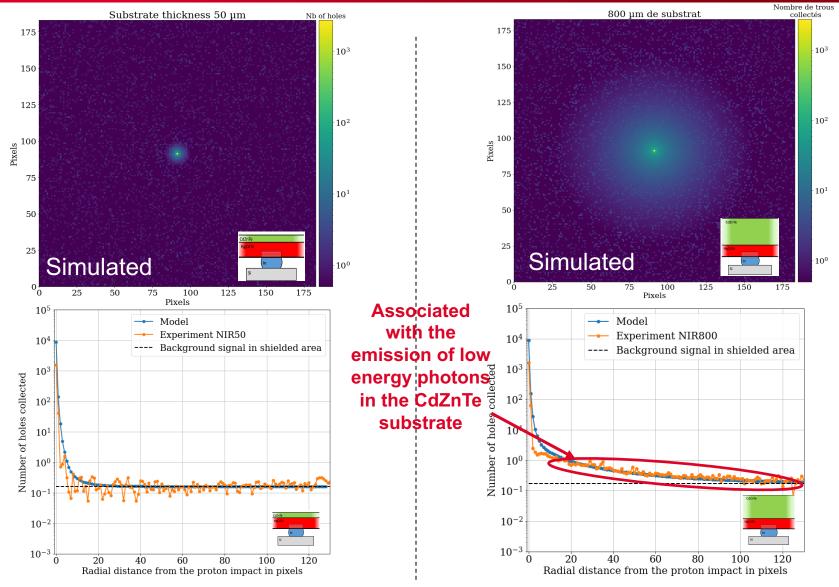
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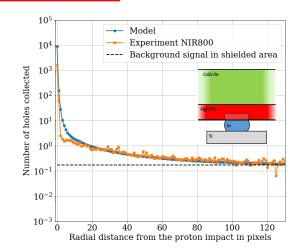
MODEL

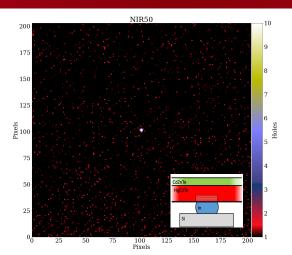
EXPERIMENTAL VALIDATION

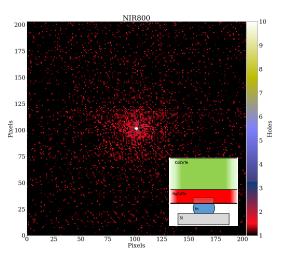
CONCLUSIONS

- No detector background elevation under irradiation in detector NIR50
- Background signal elevation under irradiation observed in detector NIR800 is attributed to the large extension of each transient event.
- According to the model this large extension of the radial profile is associated with the emission of low energy photons in the substrate.

<u>Complete removal of the CdZnTe substrate is not mandatory</u> regarding the influence of protons irradiation on the performances of IR detectors.

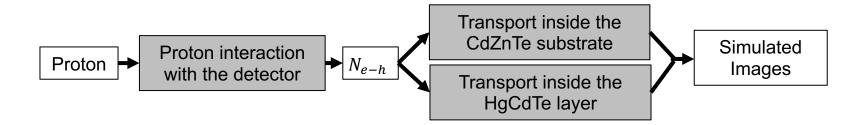








Regarding detector simulation



- A model has been developped to model the response of IR HgCdTe detectors under irradiation when the substrate is not removed.
- This model is fed with material properties measurements
- This model has been validated experimentally.
- For now it considers only normally incident protons but it can be extended to ionizing particles with different incident angles.

